

RESPONSE TO NOTICE OF NON-COMPLIANT AMENDMENT

Application No.: 09/732,712

Atty Docket No.: Q57601

**AMENDMENTS TO THE CLAIMS**

**This listing of claims will replace all prior versions and listings of claims in the application:**

**LISTING OF CLAIMS:**

Claim 1. (previously presented): A method for measuring a water concentration in liquefied ammonia having a water concentration of no more than 10 ppm, comprising:

introducing a gaseous phase moiety of liquefied ammonia, said liquefied ammonia having a water concentration of 10 ppm or less, as a reference gas into a multi-reflection long optical path cell,

measuring infrared (IR) spectrum~~absorption intensity~~ of the reference gas as a background of an IR spectrometer~~at an infrared wave number at which infrared absorptions of ammonia and water do not overlap as background absorption~~,

introducing a gas obtained by vaporizing liquefied ~~the~~ ammonia as a sample at a constant flow rate into the cell,

measuring infrared (IR) spectrum ~~absorption intensity~~ of the sample ~~at the infrared wave number, and~~employing the background of the spectrometer,

measuring absorption intensity in the IR spectrum of the sample at an infrared wave number at which water absorbs IR and at which infrared absorptions of water and ammonia do not overlap, and

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~~determining~~obtaining the water concentration based on the measured absorption intensity of the sample and the background absorption intensity of the reference gas with from a water concentration calibration curve prepared in advance.

Claim 2. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim 1, wherein the ~~measurement~~infrared wave number ~~used~~ is in the range of from 3,500 to 4,000  $\text{cm}^{-1}$ , from 2,600 to 3,100  $\text{cm}^{-1}$ , or from 1,900 to 2,400  $\text{cm}^{-1}$ .

Claim 3. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim 2, wherein said ~~measurement~~infrared wave number is one or more selected from the group consisting of 3600, 3609, 3612, 3619, 3629, 3634, 3649, 3656, 3670, 3675, 3688, 3691, 3701, 3709, 3712, 3719, 3722, 3727, 3732, 3736, 3741, 3744, 3749, 3752, 3756, 3759, 3766, 3770, 3779, 3785, 3796, 3801, 3807, 3816, 3821, 3826, 3831, 3835, 3837, 3840, 3843, 3854, 3862, 3865, 3870, 3874, 3880, 3885, 3891, 3894, 3899, 3902, and 3904  $\text{cm}^{-1}$  (variation width:  $\pm 1 \text{ cm}^{-1}$ ).

Claim 4. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim 3, wherein said ~~measurement~~infrared wave number is one or more selected from the group consisting of 3801, 3807, 3816, 3821, 3837 and 3854  $\text{cm}^{-1}$  (variation width  $\pm 1 \text{ cm}^{-1}$ ).

Claims 5 and 6. (canceled).

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Claim 7. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim ~~6~~1, wherein said ammonia has a water concentration of 1 ppm or less.

Claim 8. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim 7, wherein said ammonia has a water concentration of 0.1 ppm or less.

Claim 9. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim 1, wherein ammonia gas is introduced into said multi-reflection long optical path cell at a flow rate of from 0.1 to 5 L/min.

Claim 10. (original): The method for measuring a water concentration in liquefied ammonia as claimed in claim 1, wherein an infrared ray is multi-reflected to have an infrared optical path length of from 1 to 40 m.

Claim 11. (withdrawn): An infrared measuring apparatus comprising an infrared spectroscope, a long optical path gas cell, a flow rate controlling unit and a vaporizer, wherein ammonia gas vaporized by the vaporizer is fed into the flow rate controlling unit, the ammonia gas is introduced from the flow rate controlling unit into the long optical path gas cell at a constant flow rate, and the water content of ammonia in the long optical path gas cell is measured by the infrared spectroscope.

Claim 12. (withdrawn): The infrared measuring apparatus as claimed in claim 11, wherein said long optical path gas cell has a volume of from 0.1 to 5 L.

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Claim 13. (previously presented): A method for producing ammonia having a decreased water content, wherein the method comprises the steps of distilling crude ammonia and measuring a water concentration in ammonia using a measurement method as claimed in claim 1.

Claim 14. (previously presented): A method for producing ammonia having a decreased water content, wherein the method comprises the steps of purifying crude ammonia by contacting it with at least one purifying agent selected from the group consisting of metals, metal oxides and zeolite and measuring a water concentration in ammonia using a measurement method as claimed in claim 1.

Claim 15. (original): The method for producing ammonia as claimed in claim 13 or 14, wherein ammonia having a water content of 1 ppm or less is produced.

Claim 16. (original): The method for producing ammonia as claimed in claim 15, wherein ammonia having a water content of 0.1 ppm or less is produced.

Claim 17 (withdrawn): Ammonia having a water content decreased to 1 ppm or less produced by a method as claimed in claim 15.

Claim 18. (withdrawn): Ammonia having a water content decreased to 0.1 ppm or less produced by a method as claimed in claim 16.

Claim 19. (withdrawn): A semiconductor nitride film produced using ammonia having a decreased water content obtained by a method as claimed in any one of claims 13 to 16.

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Claim 20. (withdrawn): A group III-V compound semiconductor produced using ammonia having a decreased water content obtained by a method as claimed in any one of claims 13 to 16.

Claim 21. (withdrawn): The group III-V compound semiconductor as claimed in claim 20, wherein said group III-V compound semiconductor is  $\text{GaN}$ ,  $\text{In}_x\text{Ga}_{1-x}\text{N}$ ,  $\text{B}_x\text{Ga}_{1-x}\text{N}$ ,  $\text{Al}_x\text{Ga}_{1-x}\text{N}$ ,  $\text{In}_x\text{Al}_y\text{Ga}_{1-x-y}\text{N}$ ,  $\text{GaN}_p\text{As}_{1-p}$ ,  $\text{GaN}_p\text{As}_q\text{P}_{1-p-q}$ , or  $\text{In}_x\text{Ga}_{1-x}\text{N}_p\text{As}_{1-p}$  (provided that  $x$ ,  $y$ ,  $p$ , and  $q$  are numbers that satisfy  $0 < x, y, p, q < 1$ ).

Claim 22. (canceled).

Claim 23. (previously presented): The method for measuring a water concentration in ammonia as claimed in claim 1, wherein the gaseous phase moiety employed as the reference gas has a water concentration that is 0.01 to 0.1 times the water concentration of the liquefied ammonia.

Claim 24. (canceled).